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## Supplementary information for

## Copper-Palladium/Reduced Graphene Oxide Composite as a Catalyst for the Oxygen Reduction Reaction

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Figure S1. XRD patterns of the three RGO/metal composites.



**Figure S2**. The lattice parameter *a* versus atomic fraction *x* for the  $Cu_{1-x}Pd_x$  alloy (black diamonds) and the linear fit (blue line). The parameters of linear fit are given as inset.

\* The lattice parameters a = 3.615 Å and 3.890 Å for metallic Cu and Pd, respectively, were taken from the PDF2 powder X-ray diffraction database (card numbers [4-836] and [46-1043]). The lattice parameter a = 3.78 Å of CuPd alloy was calculated from XRD data in Fig. 1, orange curve.

**Table S1.** The results of quantitative STEM-EDX analysis for mixed CuPd nanoparticles in RGO/CuPd composite.

| Element | Line Family |       | Atomic Fr | Average | St. deviation |    |   |
|---------|-------------|-------|-----------|---------|---------------|----|---|
|         |             | 1     | 2         | 3       | 4             |    |   |
| Cu      | K           | 28.68 | 32.78     | 31.82   | 42.99         | 34 | 6 |
| Pd      | L           | 71.32 | 67.22     | 68.18   | 57.01         | 66 | 6 |

**Table S2.** The results of quantitative STEM-EDX analysis, showing the **overall** Cu and Pd mass fractions in RGO/CuPd composite.

| Element | Line Family | Ma    | ss Fraction | (%)   | Average | St. deviation |
|---------|-------------|-------|-------------|-------|---------|---------------|
|         |             | 1     | 2           | 3     |         |               |
| Cu      | K           | 50.35 | 39.69       | 32.91 | 45      | 8             |
| Pd      | L           | 49.65 | 60.31       | 67.09 | 55      | 8             |



**Figure S3.** Individual and mixed compositional EDX maps of RGO/CuPd composite. EDX spectra taken from the whole field of view and CuPd nanoparticle show the difference in the intensity of Cu-K lines.



Figure S4. EPR spectrum for GO



**Figure S5**. Electron diffraction pattern for RGO/Pd, acquired from the two different areas of the same RGO/Pd flake. (a) The regular area, evenly covered by individual Pd-NPs. (b) The area with the agglomeration of Pd-NPs.



**Figure S6**. HAADF-STEM image of RGO/CuPd (a), and Fourier transform patterns from the areas, labeled by respective letters (b-d).